

# TuffDrive<sup>®</sup> eUSB – USB 3.1 Gen 1 High Speed SSD

PE Class, SLC, 2.54mm Pin-Pitch Connector

### VTDU41PI008G-V11

Product Brief - Rev. 1.1 See Datasheet for all details



## **Description**

Virtium TuffDrive<sup>®</sup> eUSB SSDs are ideal solutions for server, networking, embedded and industrial applications that require a modest amount of storage and require a widely supported USB 3.1 Gen 1 interface. Typical applications include operating system and file storage, system level diagnostics, or as a backup repository for data in DRAM in the event of a system-level power-down.

### Features

#### Capacity

- 8 GB
- SLC NAND

#### Performance

- Sequential Read: 150 MB/s
- Sequential Write: 60 MB/s
- Voltage Supply:  $5V \pm 5\%$  or  $3.3V \pm 5\%$

#### Power Consumption<sup>(1)</sup>

- Sequential Read: 0.66 W
- Sequential Write: 0.55 W
- Idle: 0.22 W

#### Temperature Ranges

- Industrial: -40°C to 85°C
- Non-Operating: -40°C to 85°C

#### Reliability

- Flexible 96-Bit/1K BCH ECC
- MTBF: >5M hours

#### SMART Attribute Reporting

- Monitors device health
- Anticipates and predicts failures

#### **Mechanical Dimensions**

- Horizontal Mount, 2.54mm Pin-Pitch Connector
- Length x Width x Height mm (inches) 36.90 (1.553) x 26.60 (1.047) x 9.75 (0.384)

#### Compliance

- USB 3.1 Gen 1
- FCC, CE, UL, RoHS, WEEE

#### Environmental (Non-operating)

- Humidity (non-condensing): 5% to 95%
- Shock: 1500G, half-sine wave, 0.5ms duration
- Vibration: 20G, 20 Hz to 2000 Hz

(1) Based on a 5.0V power supply



Electrostatic Discharge (ESD) can damage this device. When handling the device, always wear a grounded wrist strap and use a static dissipative surface.



Any damage to the unit that occurs after its removal from the shipping package and ESD protective bag is the responsibility of the user.